Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
09265073	OVARD ET AL.

Examiner Art Unit

Nam V Nguyen 2612

SEARCHED

Class	Subclass	Date	Examiner
340	10.4;	2/9/09	NN
455	38.2; 106; 73	2/9/09	NN

SEARCH NOTES			
Search Notes	Date	Examiner	
Search EAST: uspat; us-pub; epo; jpo and derwent (updated search).	2/9/09	NN	
Search Terms: interrogation with plurality of stations; rf circuitry for different ranges.	2/9/09	NN	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/N. V. N./ Examiner.Art Unit 2612	

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